

Search Notes

Application/Control No.

10/724,471

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

ZHONG ET AL.

Art Unit

2874

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--------------------|-----------|----------|
| 385 | 15,47,88 92,130 | 7/18/2005 | JDS |
| 398 | 82,83 | 7/18/2005 | JDS |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| See attached EAST search history | 7/18/2005 | JDS |
| IEEE and INPSEC: coupler, thin film, add, drop, multiplex, demultiplex, substrate | 7/18/2005 | JDS |
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